

MOS FIELD EFFECT TRANSISTOR 2SK3116

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3116 is N-channel DMOS FET device that features a low gate charge and excellent switching characteristics, and designed for high voltage applications such as switching power supply, AC adapter.

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3116	TO-220AB		
2SK3116-S	TO-262		
2SK3116-ZJ	TO-263		

FEATURES

•Low gate charge $Q_G = 26 \text{ nC TYP.}$ (ID = 7.5 A, VDD = 450 V, VGS = 10 V) •Gate voltage rating ±30 V •Low on-state resistance $R_{DS(on)} = 1.2 \Omega \text{ MAX.}$ (VGS = 10 V, ID = 3.75 A) •Avalanche capability ratings

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$)

Drain to Source Voltage (V _{GS} = 0 V)	VDSS	600	V
Gate to Source Voltage (VDs = 0 V)	Vgss	±30	V
Drain Current (DC)	D(DC)	±7.5	А
Drain Current (pulse) Note1	D(pulse)	±30	А
Total Power Dissipation ($T_A = 25^{\circ}C$)	PT1	1.5	W
Total Power Dissipation (Tc = 25°C)	PT2	70	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	las	7.5	А
Single Avalanche Energy Note2	Eas	37.5	mJ
Diode Recovery dv/dt Note3	dv/dt	3.5	V/ns

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

- 2. Starting T_{ch} = 25°C, V_{DD} = 150 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V
- 3. IF \leq 3.0 A, V_{clamp} = 600 V, di/dt \leq 100 A/ μ s, T_A = 25°C

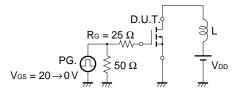
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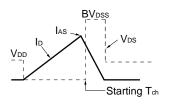
CHRACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	Vds = 600 V, Vgs = 0 V			100	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±100	nA
Gate Cut-off Voltage	VGS(off)	V _{DS} = 10 V, I _D = 1 mA	2.5		3.5	V
Forward Transfer Admittance	y _{fs}	Vds = 10 V, Id = 3.75 A	2.0			S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 3.75 A		0.9	1.2	Ω
Input Capacitance	Ciss	V _{DS} = 10 V		1100		pF
Output Capacitance	Coss	Vgs = 0 V		200		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		20		pF
Turn-on Delay Time	td(on)	Vdd = 150 V, Id = 3.75 A		18		ns
Rise Time	tr	Vgs = 10 V		15		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		50		ns
Fall Time	tr	RL = 50 Ω		15		ns
Total Gate Charge	Q _G	V _{DD} = 450 V		26		nC
Gate to Source Charge	Q _{GS}	Vgs = 10 V		6		nC
Gate to Drain Charge	Qgd	ID = 7.5 A		10		nC
Body Diode Forward Voltage	VF(S-D)	IF = 7.5 A, VGS = 0 V		1.0		V
Reverse Recovery Time	Τrr	IF = 7.5 A, VGS = 0 V		1.6		μs
Reverse Recovery Charge	Qrr	di/dt = 50 A/ μs		7.6		μC

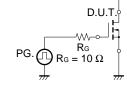
ELECTRICAL CHARACTERISTICS (TA = 25°C)

TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME

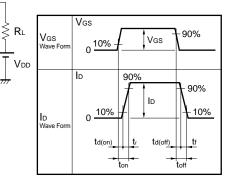




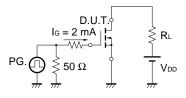




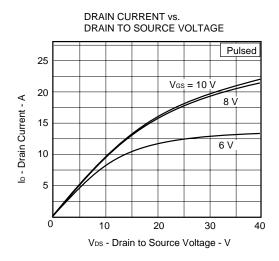
 $\begin{array}{l} \tau = 1 \; \mu s \\ \text{Duty Cycle} \leq 1\% \end{array}$



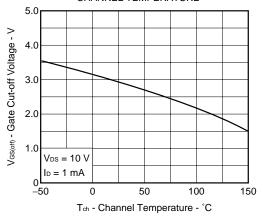
TEST CIRCUIT 3 GATE CHARGE



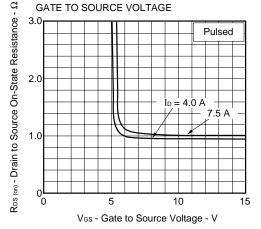
TYPICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)



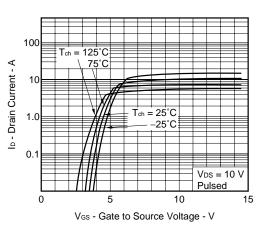




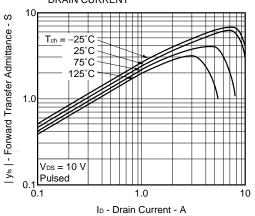
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

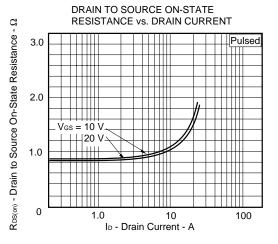


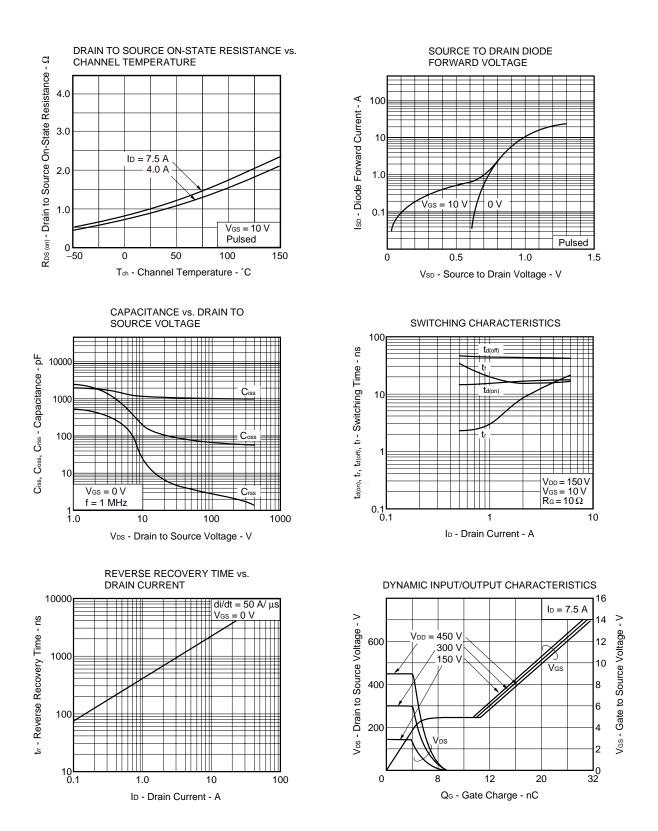
FORWARD TRANSFER CHARACTERISTICS



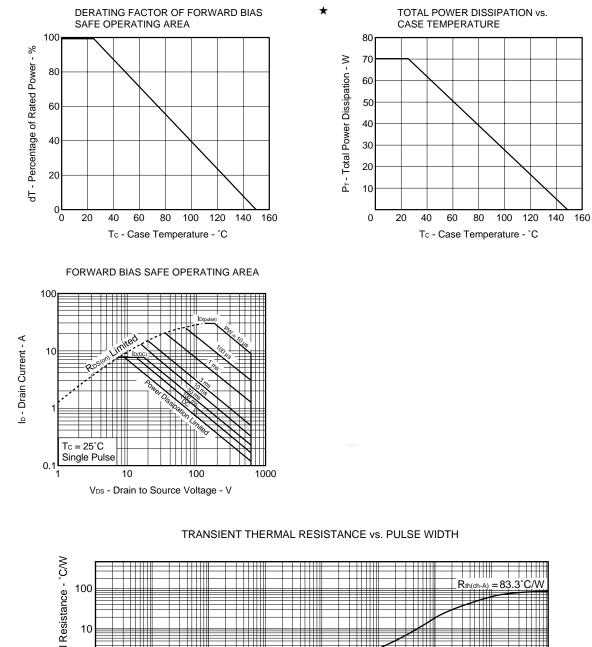
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



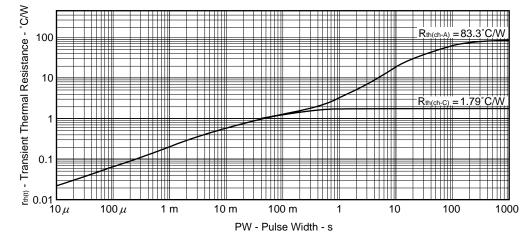




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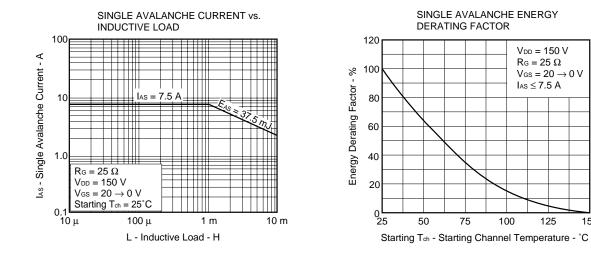


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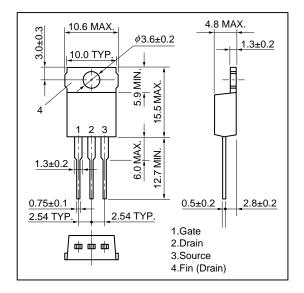
Data Sheet D13339EJ2V0DS

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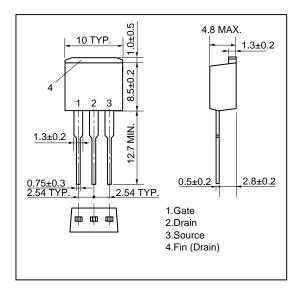


* PACKAGE DRAWINGS (Unit: mm)

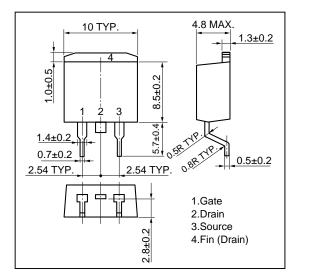
1) TO-220AB (MP-25)



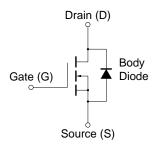
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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